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Application/Control No.	Applicant(s)/Patent under Reexamination
10/627,525	LEE ET AL.
Examiner	Art Unit
Miko Oi	2074

	SEARCHED			
Class	Subclass	Date	Examiner	
349	113,117 96,97 106	6/4/2005	ZQQ	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEAR (INCLUDING SI	CH NOTI	ES STRATEGY)
		DATE	EXMR
East serch		6/4/2005	ZQQ